

# STBV32

## HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- ST13003 SILICON IN TO-92 PACKAGE
- MEDIUM VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED

#### **APPLICATIONS:**

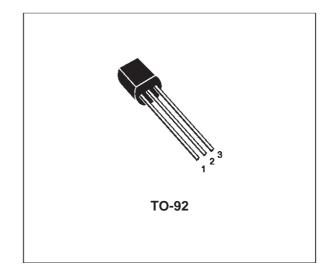
 ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING

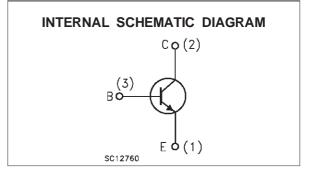
#### DESCRIPTION

The device is manufactured using high voltage Multi Epitaxial Planar technology for high switching speeds and medium voltage capability.

It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining the wide RBSOA.

The STBV32 is designed for use in compact fluorescent lamp application.





#### **ABSOLUTE MAXIMUM RATINGS**

| Symbol           | Parameter                                      | Value      | Unit |
|------------------|--|------------|------|
| V <sub>CES</sub> | Collector-Emitter Voltage ( $V_{BE} = 0$ )     | 700        | V    |
| Vceo             | Collector-Emitter Voltage (I <sub>B</sub> = 0) | 400        | V    |
| V <sub>EBO</sub> | Emitter-Base Voltage (I <sub>C</sub> = 0)      | 9          | V    |
| lc               | Collector Current                              | 1.5        | Α    |
| Ісм              | Collector Peak Current (t <sub>p</sub> < 5 ms) | 3          | А    |
| lв               | Base Current                                   | 0.75       | А    |
| I <sub>BM</sub>  | Base Peak Current (t <sub>p</sub> < 5 ms)      | 1.5        | А    |
| Ptot             | Total Dissipation at $T_c = 25$ °C             | 1.1        | W    |
| T <sub>stg</sub> | Storage Temperature                            | -65 to 150 | °C   |
| Tj               | Max. Operating Junction Temperature            | 150        | °C   |

#### THERMAL DATA

| R <sub>thj-case</sub> Thermal Resistance Junction-case | Max | 112 | °C/W |
|--|-----|-----|------|
|--|-----|-----|------|

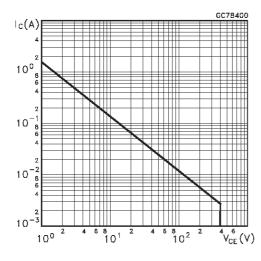
### **ELECTRICAL CHARACTERISTICS** ( $T_{case} = 25 \ ^{\circ}C$ unless otherwise specified)

| Symbol                                 | Parameter  | Test Co   | Min.  | Тур.   | Max. | Unit              |                |
|--|--|---|---|--------|------|-------------------|----------------|
| ICEV                                   | Collector Cut-off<br>Current (V <sub>BE</sub> = -1.5V)   | V <sub>CE</sub> = 700V<br>V <sub>CE</sub> = 700V          | $T_{j} = 125^{\circ}C$                              |        |      | 1<br>5            | mA<br>mA       |
| I <sub>EBO</sub>                       | Emitter Cut-off<br>Current (I <sub>C</sub> = 0)          | $V_{EB} = 9 V$  |   |        |      | 1                 | mA             |
| V <sub>CEO(sus)</sub> *                | Collector-Emitter<br>Sustaining Voltage<br>$(I_B = 0)$   | I <sub>C</sub> = 10 mA<br>L = 25 mH                       |   | 400    |      |                   | V              |
| V <sub>CE(sat)</sub> *                 | Collector-Emitter<br>Saturation Voltage                  | $I_{C} = 0.5 A$<br>$I_{C} = 1 A$<br>$I_{C} = 1.5 A$       | $I_B = 0.1 A$<br>$I_B = 0.25 A$<br>$I_B = 0.5 A$    |        |      | 0.5<br>1<br>3     | V<br>V<br>V    |
| V <sub>BE(sat)</sub> *                 | Base-Emitter<br>Saturation Voltage                       | $I_{C} = 0.5 A$ $I_{C} = 1 A$                             | I <sub>B</sub> = 0.1 A<br>I <sub>B</sub> = 0.25 A   |        |      | 1.0<br>1.2        | V<br>V         |
| h <sub>FE</sub> *                      | DC Current Gain  | $I_{C} = 0.5 A$ $I_{C} = 1 A$                             | $V_{CE} = 2 V$<br>$V_{CE} = 2 V$                    | 8<br>5 |      | 35<br>25          |                |
| t <sub>r</sub><br>t <sub>s</sub><br>tf | RESISTIVE LOAD<br>Rise Time<br>Storage Time<br>Fall Time | $I_{C} = 1 A$<br>$I_{B1} = 0.2 A$<br>$T_{p} = 25 \ \mu s$ | V <sub>CC</sub> = 125 V<br>I <sub>B2</sub> = -0.2 A |        |      | 1.0<br>4.0<br>0.7 | μs<br>μs<br>μs |
| ts                                     | INDUCTIVE LOAD<br>Storage Time                           | $I_{C} = 1 A$ $V_{BE} = -5 V$ $V_{clamp} = 300 V$         | I <sub>B1</sub> = 0.2 A<br>L = 50 mH                |        | 0.8  |                   | μs             |

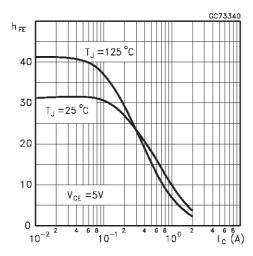
\* Pulsed: Pulse duration = 300µs, duty cycle = 1.5 %.

57

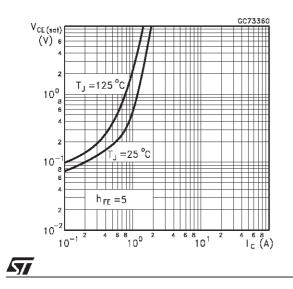
#### Safe Operating Area



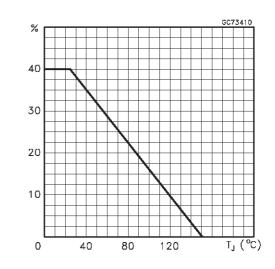
DC Current Gain



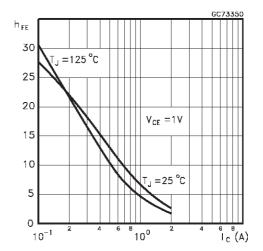
Collector Emitter Saturation Voltage



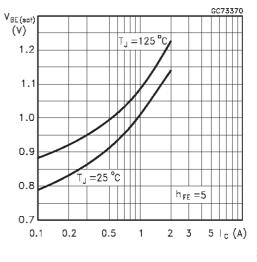
**Derating Curve** 



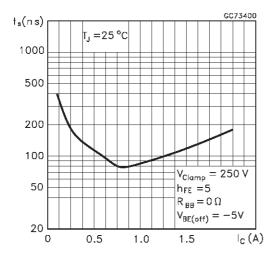




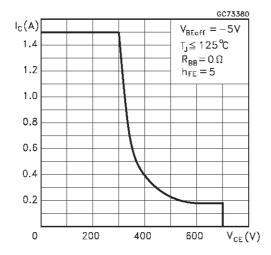




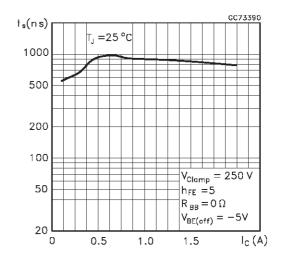
#### Inductive Fall Time



**Reverse Biased SOA** 



Inductive Storage Time



57

4/7

Figure 1: Inductive Load Switching Test Circuits.

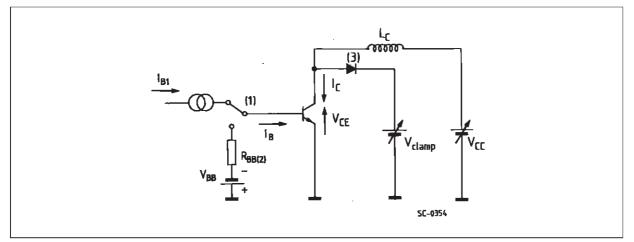
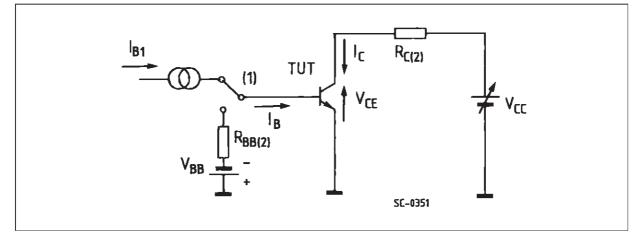
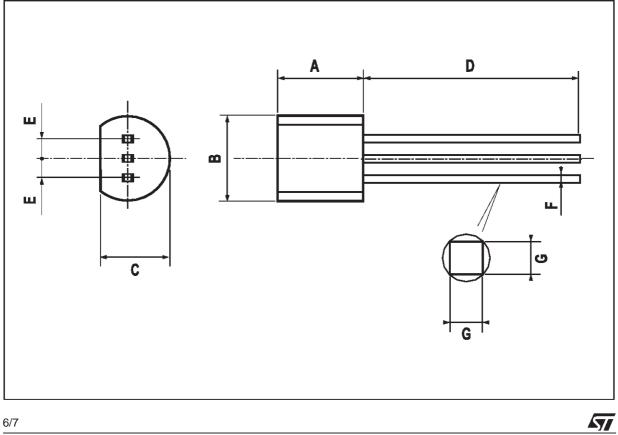


Figure 2: Resistive Load Switching Test Circuits.



| TO-92 MECHANICAL DATA |      |      |      |       |       |       |
|-----------------------|------|------|------|-------|-------|-------|
| DIM.                  | mm   |      | inch |       |       |       |
|                       | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| A                     | 4.58 |      | 5.33 | 0.180 |       | 0.210 |
| В                     | 4.45 |      | 5.2  | 0.175 |       | 0.204 |
| С                     | 3.2  |      | 4.2  | 0.126 |       | 0.165 |
| D                     | 12.7 |      |      | 0.500 |       |       |
| E                     |      | 1.27 |      |       | 0.050 |       |
| F                     | 0.4  |      | 0.51 | 0.016 |       | 0.020 |
| G                     | 0.35 |      |      | 0.14  |       |       |



6/7

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57